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LIST OF ART CITED BY APPLICANT

(PTO-1449)


 ATTY. DOCKET NO.
P-0652

 APPLN. SERIAL NO.
10/792,131

APPLICANT(S)

Jik-Dong KIM

 FILING DATE
March 4, 2004

 GROUP
2631

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
/KMB/	5,991,284	11/23/1999	Willenegger et al.			
/KMB/	6,728,218	4/27/04	Corke et al.			

U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	

U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
/KMB/	CN1363193	8/7/2002	China (full text with English Abstract)				Abstract only

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

/KMB/	Chinese Office Action dated February 24, 2006

EXAMINER

/Kevin M Burd/

DATE CONSIDERED

07/08/2007

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SHEET 1 OF 1

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P-0652APPLN. SERIAL NO.
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2611**U.S. PATENT DOCUMENTS**

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
/KMB/	6,115,427	09/05/2000	CALDERBANK et al.			

U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	

U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
/KMB/	2001-148682	05/29/2001	JAPAN			Abstract	
/KMB/	WO 02/093779	11/21/2002	PCT			X	
/KMB/	EP 1 030 463	08/23/2000	EUROPE			X	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

European Search Report dated February 8, 2007

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/Kevin M Burd/

DATE CONSIDERED

07/08/2007

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